

PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicants: Shigao Chen
Appl. No.: 10/821,461
Filed: April 9, 2004
Art Unit: 3737
Title: METHOD AND APPARATUS FOR SHEAR PROPERTY
CHARACTERIZATION FROM RESONANCE INDUCED BY
OSCILLATORY RADIATION FORCE
Examiner: Joel Lamprecht
Docket No.: 630666.91063

AMENDMENT ACCOMPANYING REQUEST FOR CONTINUED EXAMINATION

MS Amendment
Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Sir:

In response to the Office Action dated Dec. 22, 2008, the Applicants submit the following amendments and remarks.

Amendments to the Claims are reflected in the listing of claims which begins on page 2 of this paper.

Remarks/Arguments begin on page 6 of this paper.